


<b>Search Notes</b>  	<b>Application/Control No.</b>  10598234	<b>Applicant(s)/Patent Under Reexamination</b>  VAN DER TEMPEL, LEENDERT
	<b>Examiner</b>  BRENITRA M LEE	<b>Art Unit</b>  4176

SEARCHED			
Class	Subclass	Date	Examiner
313	483, 484, 487, 491, 500, 501, 503-507, 511, 512, 584, 586, 631	10/20/2008	BML

SEARCH NOTES		
Search Notes	Date	Examiner
Classification search, IEEE XPlore, Inspec, Google Scholar, EAST Text Search	10/20/2008	BML

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/BRENITRA M LEE/ Examiner.Art Unit 4176	
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